Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination NAKANO ET AL. | Examiner | Art Unit | Kevin M. Nguyen | 2629 | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,215,479	04-2001	Matsui, Katsuichi	345/173
*	В	US-6,380,929	04-2002	Platt, John C.	345/173
*	С	US-6,088,023	07-2000	Louis et al.	345/173
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0		<u> </u>			
	Р					
	Q					
	R					
	s					
	Т				3.4.6	

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
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	w		
	x		

^{*}A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.